



# DIM800ACM45-TS000

# **IGBT Chopper Module**

DS6187-4 August 2023 (LN42740)

## **FEATURES**

Replaces DS6187-3

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base With AIN Substrates
- Lead Free Construction

#### **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800ACM45-TS000 is a 4500V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### **ORDERING INFORMATION**

Order As:

## DIM800ACM45-TS000

Note: When ordering, please use the complete part number

## **KEY PARAMETERS**

Vces		4500V
V <sub>CE(sat)</sub>	* (typ)	2.5V
l <sub>c</sub>	(max)	800A
I <sub>C(PK)</sub>	(max)	1600A

<sup>\*</sup> Measured at the auxiliary terminals

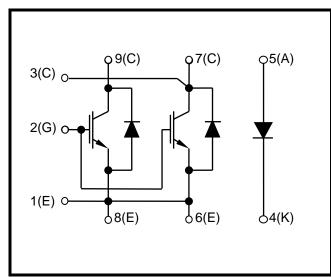


Fig. 1 Circuit configuration



Fig. 2 Package

## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Vces	Collector-emitter voltage	V <sub>GE</sub> = 0V	4500	V
V <sub>GES</sub>	Gate-emitter voltage		±20	V
Ic	Continuous collector current	T <sub>case</sub> = 90°C	800	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 115°C	1600	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 125^{\circ}C$	8.3	kW
l²t	Diode I <sup>2</sup> t value	$V_R = 0$ , $t_p = 10$ ms, $T_j = 125$ °C	205	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	7.4	kV
$Q_{PD}$	Partial discharge – per module	IEC1287, V <sub>1</sub> = 4800V, V <sub>2</sub> = 3500V, 50Hz RMS	10	рС

## THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

56mm

26mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	12	°C/kW
D	Thermal resistance – diode (IGBT arm)	Continuous dissipation - junction to case	-	-	24	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (Diode arm)		-	-	24	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
	Junction temperature	Transistor	-	-	125	°C
Tj		Diode	-	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	-	-	5	Nm
		Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

## **ELECTRICAL CHARACTERISTICS**

 $T_{case}$  = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Ices	Collector cut-off current	V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub>			1	mA
		V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub> , T <sub>case</sub> = 125°C			40	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V$ , $V_{CE} = 0V$			1	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	Ic = 80mA, V <sub>GE</sub> = V <sub>CE</sub>		5.8		V
	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 800A		2.5		V
$V_{CE(sat)}$		V <sub>GE</sub> = 15V, I <sub>C</sub> = 800A, T <sub>j</sub> = 125°C		3.2		V
l <sub>F</sub>	Diode forward current	DC		800		Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		1600		Α
	Diode forward voltage	I <sub>F</sub> = 800A		2.9		V
VF		I <sub>F</sub> = 800A, T <sub>j</sub> = 125°C		3.1		V
Cies	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		100		nF
Qg	Gate charge	±15V		15		μC
Cres	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		8		nF
L <sub>M</sub>	Module inductance			15		nH
	Internal transistor resistance (IGBT arms)			135		μΩ
RINT	Internal transistor resistance (Diode arm)			270		μΩ
SC <sub>Data</sub>	Short circuit current, Isc	$\begin{split} T_{j} &= 125^{\circ}\text{C}, \ V_{CC} = 3400\text{V} \\ t_{p} &\leq 10 \mu\text{s}, \ V_{GE} \leq 15\text{V} \\ V_{CE \ (max)} &= V_{CES} - L^{*} \ x \ dI/dt \\ IEC \ 60747-9 \end{split}$		3200		А

## Note:

 $<sup>^{\</sup>star}$  L is the circuit inductance + L<sub>M</sub>

## **ELECTRICAL CHARACTERISTICS**

 $T_{case} = 25$ °C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	$I_{C} = 800A$ $V_{GE} = \pm 15V$ $V_{CE} = 2800V$ $R_{G(ON)} = 3.9\Omega$ $R_{G(OFF)} = 3.9\Omega$ $C_{ge} = 150nF$ $L_{S} \sim 165nH$		2800		ns
<b>t</b> f	Fall time			530		ns
Eoff	Turn-off energy loss			2500		mJ
t <sub>d(on)</sub>	Turn-on delay time			1000		ns
t <sub>r</sub>	Rise time			160		ns
E <sub>ON</sub>	Turn-on energy loss			3500		mJ
Qrr	Diode reverse recovery charge	I <sub>F</sub> = 800A V <sub>CE</sub> = 2800V dI <sub>F</sub> /dt = 1900A/μs		880		μC
Irr	Diode reverse recovery current			680		Α
E <sub>rec</sub>	Diode reverse recovery energy			1100		mJ

## T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time			2900		ns
t <sub>f</sub>	Fall time	Ic = 800A V <sub>GE</sub> = ±15V		490		ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 2800V		2600		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 3.9\Omega$ $R_{G(OFF)} = 3.9\Omega$ $C_{ge} = 150 \text{nF}$ $L_S \sim 165 \text{nH}$		1000		ns
tr	Rise time			170		ns
Eon	Turn-on energy loss			4800		mJ
Qrr	Diode reverse recovery charge	I <sub>F</sub> = 800A		1450		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 2800V		750		Α
Erec	Diode reverse recovery energy	dl <sub>F</sub> /dt = 2000A/µs		2000		mJ

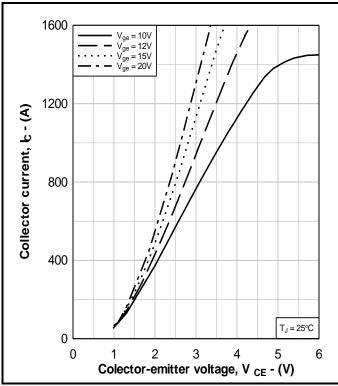


Fig. 3 Typical output characteristics

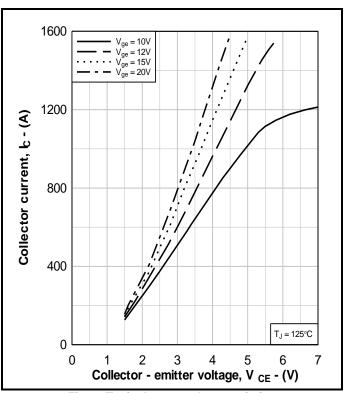


Fig. 4 Typical output characteristics

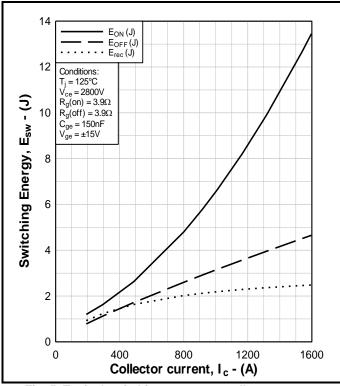


Fig. 5 Typical switching energy vs collector current

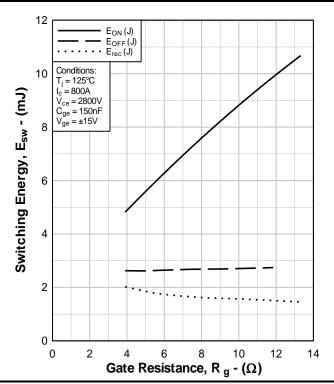


Fig. 6 Typical switching energy vs gate resistance

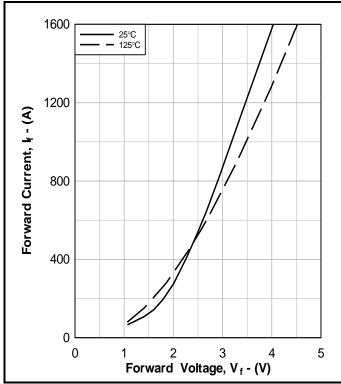


Fig. 7 Diode typical forward characteristics

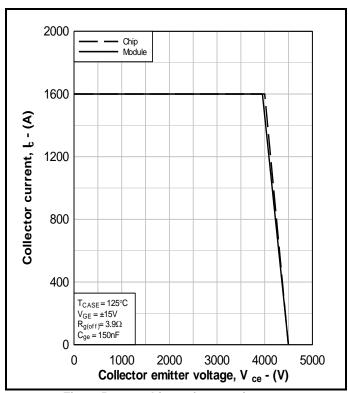


Fig. 8 Reverse bias safe operating area

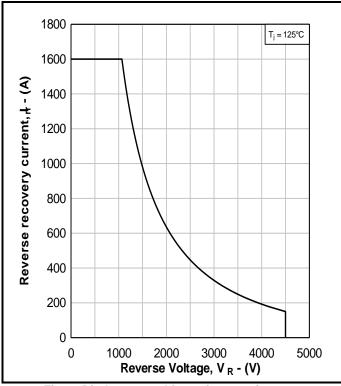


Fig. 9 Diode reverse bias safe operating area

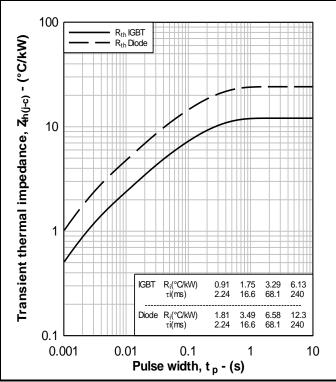


Fig. 10 Transient thermal impedance

## **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

## DO NOT SCALE.

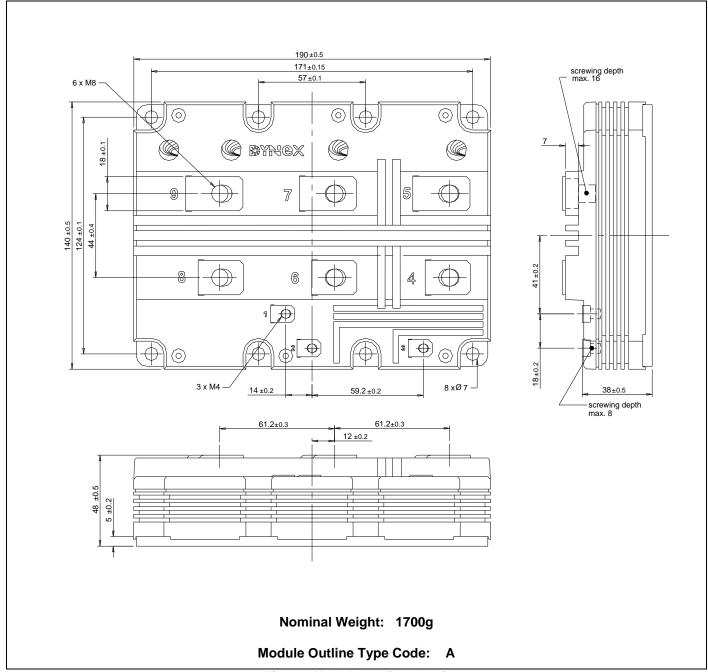


Fig. 11 Module outline drawing

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## DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln, Lincolnshire, LN6 3LF,

United Kingdom

Fax: +44(0)1522 500550 Tel: +44(0)1522 500500 Web: http://www.dynexsemi.com

## **CUSTOMER SERVICE**

## DYNEX SEMICONDUCTOR LTD

Doddington Road, Lincoln, Lincolnshire, LN6 3LF, United Kingdom

+44(0)1522 502753 / 502901 Tel: powersolutions@dynexsemi.com Email:

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